

## General Description

The series of devices use advanced trench gate super junction technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

## Features

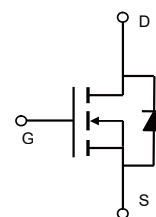
- Optimized body diode reverse recovery performance
- Low on-resistance and low conduction losses
- Small package
- Ultra Low Gate Charge cause lower driving requirements
- 100% Avalanche Tested
- ROHS compliant

## Application

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)
- LLC Half-bridge



TO-252



Schematic

| Parameter                                                   | Symbol          | Value      | Unit          |
|-------------------------------------------------------------|-----------------|------------|---------------|
| Drain-Source Voltage ( $V_{GS}=0V$ )                        | $V_{DS}$        | 600        | V             |
| Gate-Source Voltage ( $V_{DS}=0V$ ) AC ( $f>1$ Hz)          | $V_{GS}$        | $\pm 30$   | V             |
| Gate-Source Voltage ( $V_{DS}=0V$ ) DC                      | $V_{GS}$        | $\pm 20$   | V             |
| Continuous Drain Current at $T_c=25^\circ C$                | $I_{D(DC)}$     | 21         | A             |
| Continuous Drain Current at $T_c=100^\circ C$               | $I_{D(DC)}$     | 14.7       | A             |
| Pulsed drain current (Note 1)                               | $I_{DM(pluse)}$ | 63         | A             |
| Maximum Power Dissipation( $T_c=25^\circ C$ )               | $P_D$           | 194        | W             |
| Derate above $25^\circ C$                                   |                 | 1.29       | W/ $^\circ C$ |
| Avalanche current (Note 1)                                  | $I_{AS}$        | 4          | A             |
| Drain Source voltage slope, $V_{DS} \leq 480$ V,            | $dv/dt$         | 50         | V/ns          |
| Reverse diode $dv/dt$ , $V_{DS} \leq 480$ V, $I_{SD} < I_D$ | $dv/dt$         | 50         | V/ns          |
| Operating Junction and Storage Temperature Range            | $T_J, T_{STG}$  | -55...+175 | $^\circ C$    |

\* limited by maximum junction temperature

**Table 2. Thermal Characteristic**

| Parameter                                         | Symbol     | Value | Unit                        |
|---------------------------------------------------|------------|-------|-----------------------------|
| Thermal Resistance, Junction-to-Case (Maximum)    | $R_{thJC}$ | 0.77  | $^{\circ}\text{C}/\text{W}$ |
| Thermal Resistance, Junction-to-Ambient (Maximum) | $R_{thJA}$ | 62    | $^{\circ}\text{C}/\text{W}$ |

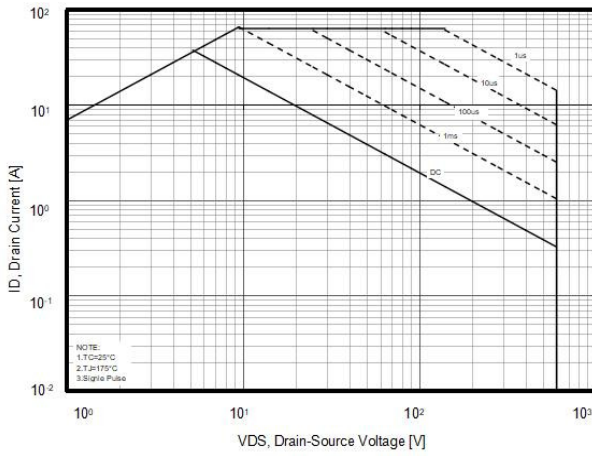
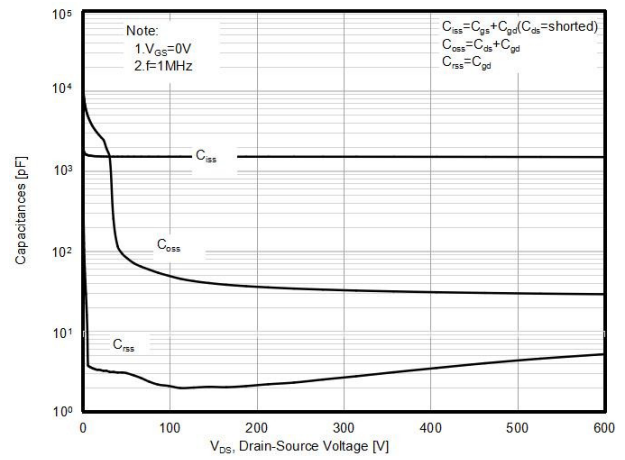
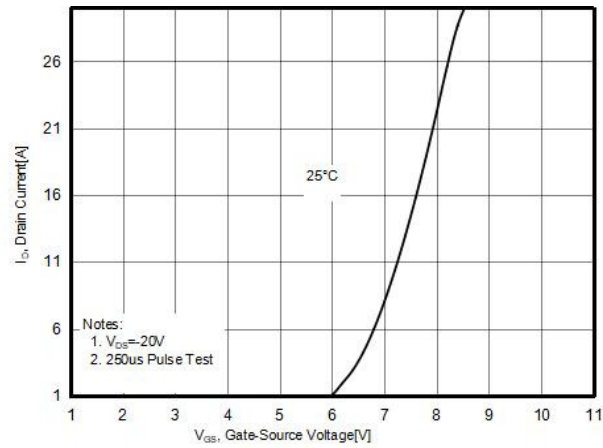
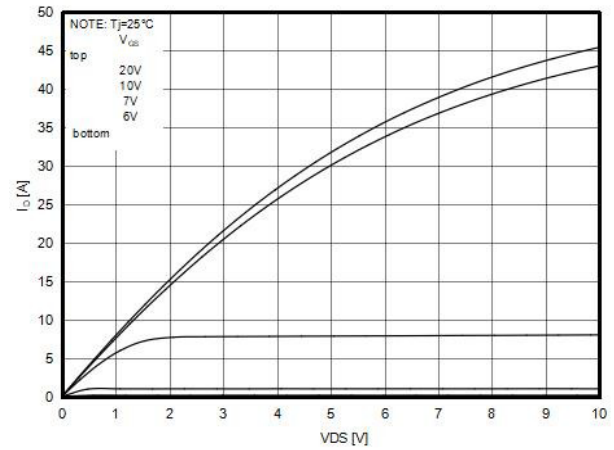
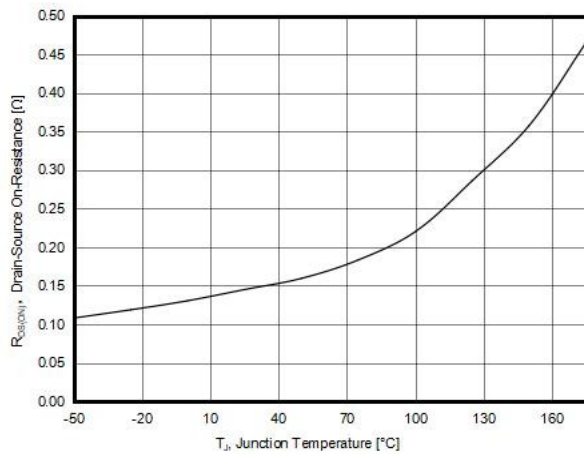
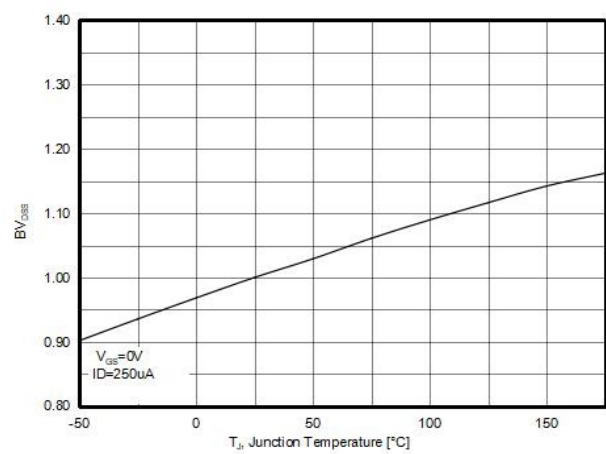
**Table 3. Electrical Characteristics ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)**

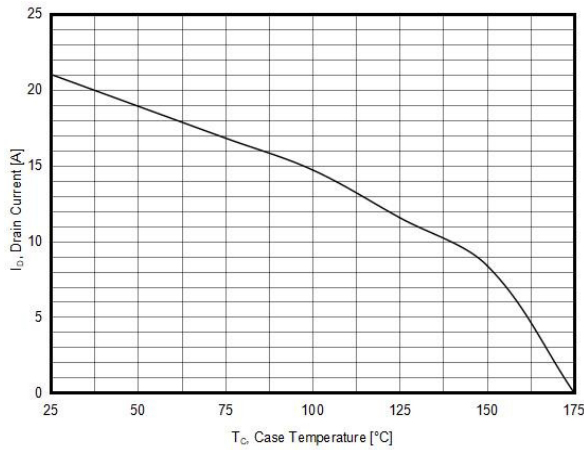
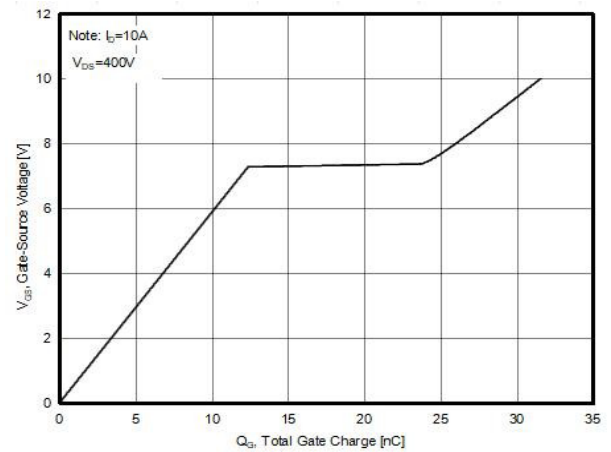
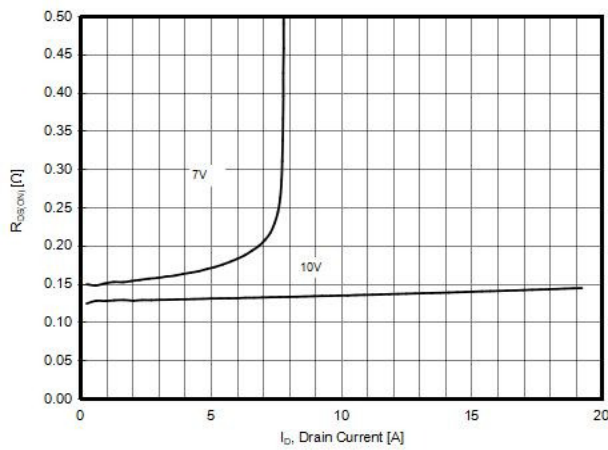
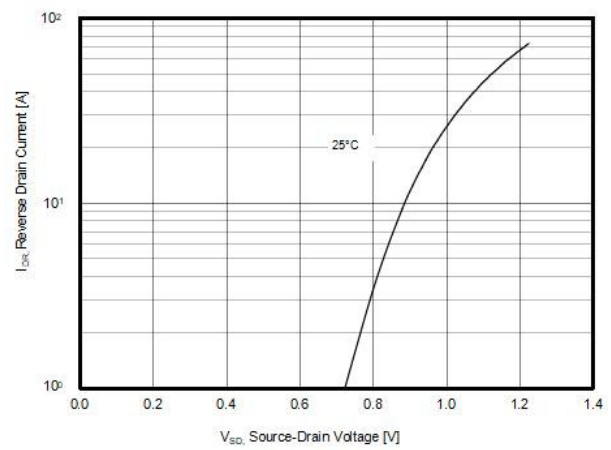
| Parameter                                | Symbol              | Condition                                                                                   | Min | Typ  | Max  | Unit |
|------------------------------------------|---------------------|---------------------------------------------------------------------------------------------|-----|------|------|------|
| On/off states                            |                     |                                                                                             |     |      |      |      |
| Drain-Source Breakdown Voltage           | BV <sub>DSS</sub>   | V <sub>GS</sub> =0V I <sub>D</sub> =250μA                                                   | 600 |      |      | V    |
| Zero Gate Voltage Drain Current(Tc=25℃)  | I <sub>DSS</sub>    | V <sub>DS</sub> =600V, V <sub>GS</sub> =0V                                                  |     |      | 10   | μA   |
| Zero Gate Voltage Drain Current(Tc=125℃) | I <sub>DSS</sub>    | V <sub>DS</sub> =600V, V <sub>GS</sub> =0V                                                  |     |      | 400  | μA   |
| Gate-Body Leakage Current                | I <sub>GSS</sub>    | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V                                                  |     |      | ±100 | nA   |
| Gate Threshold Voltage                   | V <sub>GS(th)</sub> | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                    | 3.5 | 4.2  | 5    | V    |
| Drain-Source On-State Resistance         | R <sub>DS(ON)</sub> | V <sub>GS</sub> =10V, I <sub>D</sub> =10.5A                                                 |     | 145  | 160  | mΩ   |
| Dynamic Characteristics                  |                     |                                                                                             |     |      |      |      |
| Input Capacitance                        | C <sub>iss</sub>    | V <sub>DS</sub> =50V, V <sub>GS</sub> =0V,<br>F=1.0MHz                                      |     | 1499 | 1700 | pF   |
| Output Capacitance                       | C <sub>oss</sub>    |                                                                                             |     | 80   |      | pF   |
| Reverse Transfer Capacitance             | C <sub>rss</sub>    |                                                                                             |     | 3.0  |      | pF   |
| Total Gate Charge                        | Q <sub>g</sub>      | V <sub>DS</sub> =400V, I <sub>D</sub> =10A,<br>V <sub>GS</sub> =10V                         |     | 31.6 |      | nC   |
| Gate-Source Charge                       | Q <sub>gs</sub>     |                                                                                             |     | 12.4 |      | nC   |
| Gate-Drain Charge                        | Q <sub>gd</sub>     |                                                                                             |     | 11.4 |      | nC   |
| Gate plateau voltage                     | V <sub>gp</sub>     |                                                                                             |     | 7.2  |      | V    |
| Intrinsic gate resistance                | R <sub>G</sub>      | f = 1 MHz open drain                                                                        |     | 2    |      | Ω    |
| Switching times                          |                     |                                                                                             |     |      |      |      |
| Turn-on Delay Time                       | t <sub>d(on)</sub>  | V <sub>DD</sub> =380V, I <sub>D</sub> =10.5A,<br>R <sub>G</sub> =1.7Ω, V <sub>GS</sub> =10V |     | 42   |      | nS   |
| Turn-on Rise Time                        | t <sub>r</sub>      |                                                                                             |     | 18   |      | nS   |
| Turn-Off Delay Time                      | t <sub>d(off)</sub> |                                                                                             |     | 90   |      | nS   |
| Turn-Off Fall Time                       | t <sub>f</sub>      |                                                                                             |     | 24   |      | nS   |
| Source- Drain Diode Characteristics      |                     |                                                                                             |     |      |      |      |
| Source-drain current(Body Diode)         | I <sub>SD</sub>     | T <sub>C</sub> =25℃                                                                         |     |      | 21   | A    |
| Pulsed Source-drain current(Body Diode)  | I <sub>SDM</sub>    |                                                                                             |     |      | 63   | A    |
| Forward On Voltage                       | V <sub>SD</sub>     | T <sub>J</sub> =25℃, I <sub>SD</sub> =21A, V <sub>GS</sub> =0V                              |     | 0.9  | 1.2  | V    |
| Reverse Recovery Time                    | t <sub>rr</sub>     | T <sub>J</sub> =25℃, I <sub>F</sub> =10.5A,<br>di/dt=100A/μs                                |     | 113  |      | nS   |
| Reverse Recovery Charge                  | Q <sub>rr</sub>     |                                                                                             |     | 0.5  |      | uC   |
| Peak Reverse Recovery Current            | I <sub>rrm</sub>    |                                                                                             |     | 8    |      | A    |

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2.  $T_J=25^{\circ}\text{C}, V_{DD}=50V, V_G=10V, R_G=25\Omega$

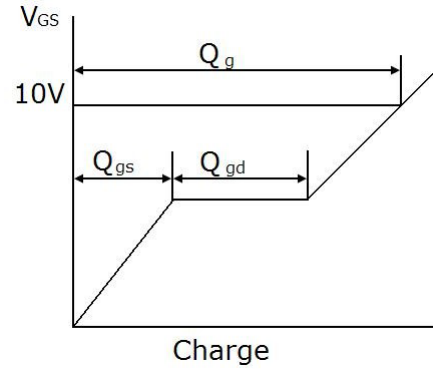
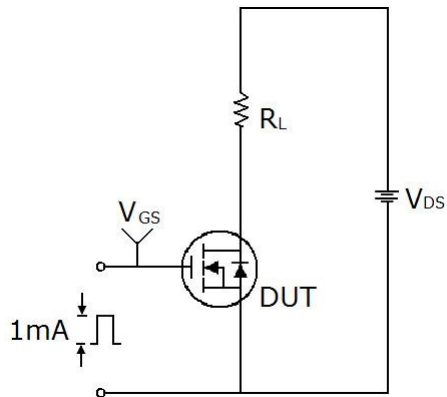
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

**Figure1. Safe operating area**

**Figure2. Capacitance**

**Figure3. Transfer characteristics**

**Figure4. Output characteristics**

**Figure5.  $R_{DS(ON)}$  vs Junction Temperature**

**Figure6.  $BV_{DSS}$  vs Junction Temperature**


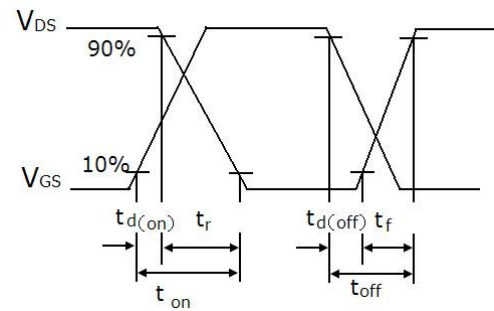
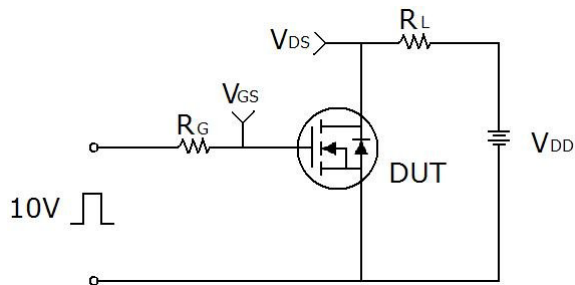
**Figure7. Maximum  $I_D$  vs Junction Temperature**

**Figure8. Gate charge waveforms**

**Figure9. Static drain-source on resistance**

**Figure10. Source-Drain Diode Forward Voltage**


## Test circuit

### 1) Gate charge test circuit & Waveform



### 2) Switch Time Test Circuit:



### 3) Unclamped Inductive Switching Test Circuit & Waveforms

